

2N4955 • 2N4956

NPN LOW-LEVEL, LOW-NOISE DIFFERENTIAL AMPLIFIERS

DIFFUSED SILICON PLANAR* TRANSISTORS

- BETA MATCH -- 20% MAX. AT 100 μ A.
- V_{BE} TRACKING -- 20 μ V/ $^{\circ}$ C MAX. AT 100 μ A FROM -40° C TO $+85^{\circ}$ C.
- V_{BE} MATCH -- 5.0 mV MAX. AT 100 μ A.
- h_{FE} -- 100 MIN. AT 100 μ A; 60 MIN. AT 10 μ A.
- LOW NOISE FIGURE -- 4.5 dB MAX.
- SOLID PACKAGE TO GIVE MAXIMUM MECHANICAL SUPPORT TO THE CHIP.

ABSOLUTE MAXIMUM RATINGS [Note 1]

Maximum Temperatures

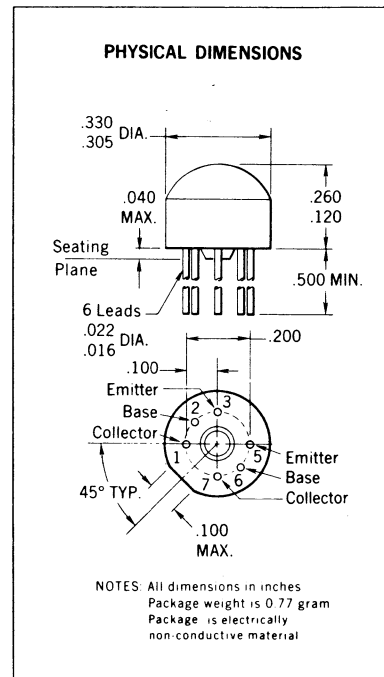
Storage Temperature	-55° C to $+125^{\circ}$ C
Operating Junction Temperature	$+125^{\circ}$ C
Lead Temperature (Soldering, 10 seconds Time Limit)	$+260^{\circ}$ C

Maximum Power Dissipation [Note 2 and 3]

Total Dissipation at 25° C Case Temperature	One Side	Both Sides
at 25° C Ambient Temperature	0.75 Watt	1.3 Watts
	0.35 Watt	0.45 Watt

Maximum Voltages and Current for Each Transistor

V_{CBO} Collector to Base Voltage	30 Volts
V_{CEO} Collector to Emitter Voltage [Note 4]	25 Volts
V_{EBO} Emitter to Base Voltage	5.0 Volts
I_C Collector Current	30 mA



MATCHING AND ELECTRICAL CHARACTERISTICS FOR 2N4956 (25° C Free Air Temperature unless otherwise noted)

SYMBOL	CHARACTERISTICS	For 2N4956 only		UNITS	TEST CONDITIONS
		MIN.	MAX.		
$\frac{h_{FE1}}{h_{FE2}}$	DC Current Gain Ratio [Note 5]	0.8	1.0		$I_C = 100 \mu$ A $V_{CE} = 5.0$ V
$(V_{BE1} - V_{BE2})$	Base-Emitter Voltage Differential [Note 6]		10	mV	$I_C = 10 \mu$ A to 1.0 mA $V_{CE} = 5.0$ V
$(V_{BE1} - V_{BE2})$	Base-Emitter Voltage Differential [Note 6]		5.0	mV	$I_C = 100 \mu$ A $V_{CE} = 5.0$ V
$\Delta(V_{BE1} - V_{BE2})$	Base-Emitter Voltage Differential Change ($T_A = -40^{\circ}$ C to $+25^{\circ}$ C) [Note 6]		1.3	mV	$I_C = 100 \mu$ A $V_{CE} = 5.0$ V
			(20 μ V/ $^{\circ}$ C)		
$\Delta(V_{BE1} - V_{BE2})$	Base-Emitter Voltage Differential Change ($T_A = +25^{\circ}$ C to $+85^{\circ}$ C) [Note 6]		1.2	mV	$I_C = 100 \mu$ A $V_{CE} = 5.0$ V
			(20 μ V/ $^{\circ}$ C)		

NOTES:

1. These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
2. These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
3. These ratings give a maximum junction temperature of 125° C and junction to case thermal resistance of 133° C/Watt (derating factor of 7.5 mW/ $^{\circ}$ C) for one side; and 77° C/Watt (derating factor of 13 mW/ $^{\circ}$ C) for both sides. Junction to ambient thermal resistance of 286° C/Watt (derating factor of 3.5 mW/ $^{\circ}$ C) for one side; and 222° C/Watt (derating factor of 4.5 mW/ $^{\circ}$ C) for both sides.
4. Rating refers to a high-current point where collector-to-emitter voltage is lowest.
5. Lowest of two h_{FE} readings is taken as h_{FE1} for purposes of this ratio.
6. Absolute values.
7. Pulse Conditions: length = 300 μ s; duty cycle = 1%.

* Planar is a patented Fairchild process.



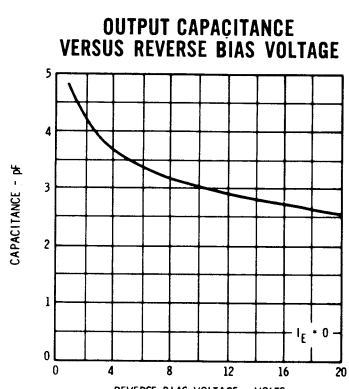
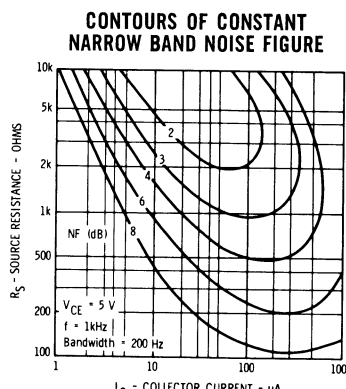
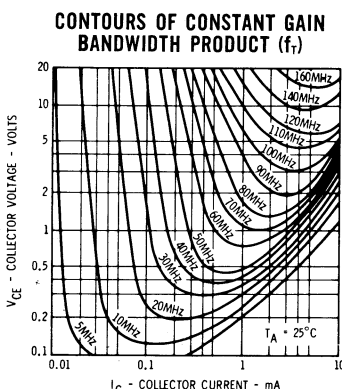
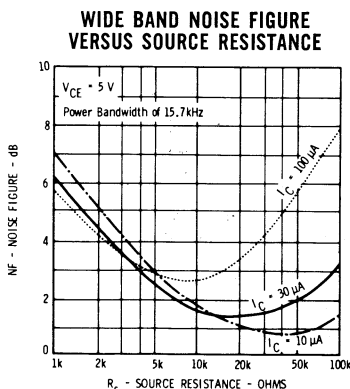
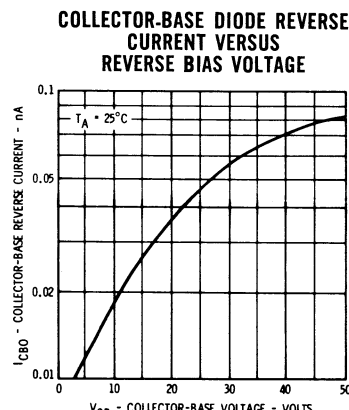
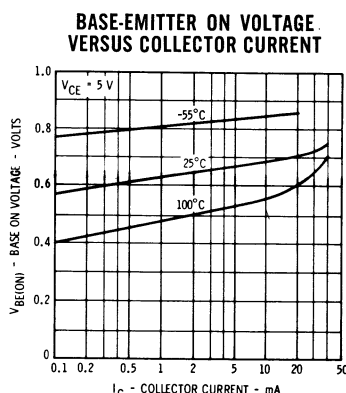
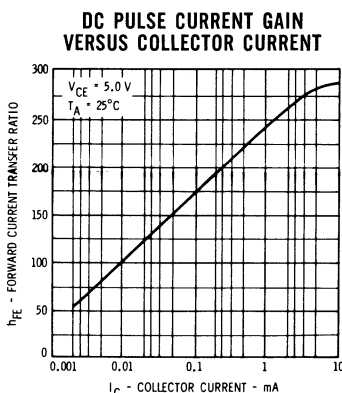
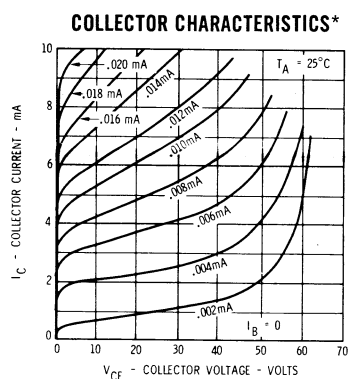
313 FAIRCHILD DRIVE, MOUNTAIN VIEW, CALIFORNIA, (415) 962-5011, TWX: 910-379-6435

FAIRCHILD TRANSISTORS 2N4955 • 2N4956

ELECTRICAL CHARACTERISTICS (25°C Free Air Temperature unless otherwise noted)

SYMBOL	CHARACTERISTIC	MIN.	MAX.	UNITS	TEST CONDITIONS
h_{FE}	DC Current Gain	150			$I_C = 1.0 \text{ mA}$ $V_{CE} = 5.0 \text{ V}$
h_{FE}	DC Current Gain	100			$I_C = 100 \mu\text{A}$ $V_{CE} = 5.0 \text{ V}$
h_{FE}	DC Current Gain	60	600		$I_C = 10 \mu\text{A}$ $V_{CE} = 5.0 \text{ V}$
$V_{CE(sat)}$	Collector Saturation Voltage		0.35	Volts	$I_C = 1.0 \text{ mA}$ $I_B = 0.1 \text{ mA}$
$V_{BE(on)}$	Emitter-Base On Voltage		0.7	Volts	$I_C = 0.1 \text{ mA}$ $V_{CE} = 5.0 \text{ V}$
I_{CBO}	Collector Cutoff Current		10	nA	$I_E = 0$ $V_{CB} = 25 \text{ V}$
$I_{CBO(85^\circ\text{C})}$	Collector Cutoff Current		1.0	μA	$I_E = 0$ $V_{CB} = 25 \text{ V}$
I_{CEO}	Collector Cutoff Current		10	nA	$I_B = 0$ $V_{CE} = 5.0 \text{ V}$
I_{EBO}	Emitter Cutoff Current		10	nA	$I_C = 0$ $V_{EB} = 5.0 \text{ V}$
C_{cb}	Collector-Base Capacitance		6.0	pF	$I_E = 0$ $V_{CB} = 10 \text{ V}$
h_{fe}	High Frequency Current Gain (f = 20 MHz)	3.0	15		$I_C = 1.0 \text{ mA}$ $V_{CE} = 5.0 \text{ V}$
h_{fe}	Small Signal Current Gain (f = 1.0 kHz)	150	1000		$I_C = 1.0 \text{ mA}$ $V_{CE} = 5.0 \text{ V}$
h_{ie}	Input Impedance (f = 1.0 kHz)	3.5	30	kohms	$I_C = 1.0 \text{ mA}$ $V_{CE} = 5.0 \text{ V}$
h_{oe}	Output Conductance (f = 1.0 kHz)		40	μmhos	$I_C = 1.0 \text{ mA}$ $V_{CE} = 5.0 \text{ V}$
h_{re}	Voltage Feedback Ratio (f = 1.0 kHz)		800	$\times 10^{-6}$	$I_C = 1.0 \text{ mA}$ $V_{CE} = 5.0 \text{ V}$
BV_{CBO}	Collector to Base Breakdown Voltage	30		Volts	$I_C = 10 \mu\text{A}$ $I_E = 0$
$V_{CEO(sust)}$	Collector to Emitter Sustaining Voltage (pulsed, notes 4 and 7)	25		Volts	$I_C = 2.0 \text{ mA}$ $I_B = 0$
BV_{EBO}	Emitter to Base Breakdown Voltage	5.0		Volts	$I_E = 10 \mu\text{A}$ $I_C = 0$
C_{eb}	Emitter-Base Capacitance		6.0	pF	$I_C = 0$ $V_{EB} = 0.5 \text{ V}$
NF	Narrow Band Noise Figure (f = 1.0 kHz)		4.5	dB	$I_C = 10 \mu\text{A}$ $V_{CE} = 5.0 \text{ V}$ B.W. = 200 Hz $R_S = 10 \text{ k}\Omega$
NF	Wide Band Noise Figure (3.0 dB points @ 10 Hz and 10 kHz)		4.5	dB	$I_C = 10 \mu\text{A}$ $V_{CE} = 5.0 \text{ V}$ B.W. = 15.7 kHz $R_S = 10 \text{ k}\Omega$

TYPICAL ELECTRICAL CHARACTERISTICS



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NPN GENERAL PURPOSE AMPLIFIERS AND SWITCHES

DIFFUSED SILICON PLANAR* EPITAXIAL TRANSISTORS

- V_{CE0} -- 80 VOLTS MIN.
- h_{FE} -- 12 SPECIFICATIONS FROM 100 μ A TO 500 mA;
-55°C TO +125°C
- $V_{CE(sat)}$ -- 0.5 V MAX. AT 500 mA; 0.18 V MAX. AT 150 mA
- f_T -- 250 MHz MIN. AT 50 mA

ABSOLUTE MAXIMUM RATINGS (Note 1)

Maximum Temperatures

Storage Temperature	-65°C to +200°C
Operating Junction Temperature	+200°C

Maximum Power Dissipation (Note 2 & 3)

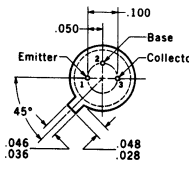
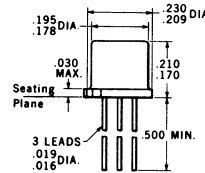
2N4960 2N4961 2N4962 2N4963

Total Dissipation at Case Temperature, 25°C	3.5	3.5	1.5	1.5	Watts
at Ambient Temperature, 25°C	0.8	0.8	0.5	0.5	Watts

Maximum Voltages

V_{CB0} Collector to Base Voltage	60	80	60	80	Volts
V_{CE0} Collector to Emitter Voltage (Note 4)	60	80	60	80	Volts
V_{EB0} Emitter to Base Voltage	6.5	6.5	6.5	6.5	Volts

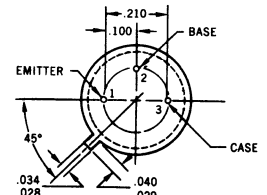
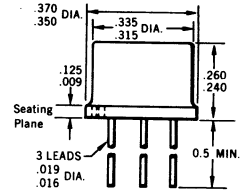
PHYSICAL DIMENSIONS in accordance with JEDEC (TO-18) outline



NOTES: All dimensions in inches
Leads are gold-plated kovar
Collector internally connected to case
Package weight is 0.43 gram

2N4962 · 2N4963

PHYSICAL DIMENSIONS in accordance with JEDEC (TO-39) outline



NOTES: All dimensions in inches
Leads are gold-plated KOVAR
Lead No. 3 internally connected to case
Package weight is 1.23 grams

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ELECTRICAL CHARACTERISTICS (25°C Free Air Temperature unless otherwise noted)

SYMBOL	CHARACTERISTICS	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	UNITS	TEST CONDITIONS
h_{FE}	DC Current Gain	30	60		30	60			$I_C = 100 \mu A$ $V_{CE} = 10 V$
h_{FE}	DC Current Gain	60	100		60	100			$I_C = 1.0 mA$ $V_{CE} = 10 V$
h_{FE}	DC Pulse Current Gain (Note 5)	90	140		90	140			$I_C = 10 mA$ $V_{CE} = 10 V$
h_{FE}	DC Pulse Current Gain (Note 5)	100	150		100	150			$I_C = 50 mA$ $V_{CE} = 10 V$
$h_{FE} (-55^\circ C)$	DC Pulse Current Gain (Note 5)	10	40		10	40			$I_C = 150 mA$ $V_{CE} = 1.0 V$
h_{FE}	DC Pulse Current Gain (Note 5)	40	100		40	100			$I_C = 150 mA$ $V_{CE} = 1.0 V$
$h_{FE} (125^\circ C)$	DC Pulse Current Gain (Note 5)		130	500		130	500		$I_C = 150 mA$ $V_{CE} = 1.0 V$
$h_{FE} (-55^\circ C)$	DC Pulse Current Gain (Note 5)	25	60		25	60			$I_C = 150 mA$ $V_{CE} = 10 V$
h_{FE}	DC Pulse Current Gain (Note 5)	100	180	300	100	180	300		$I_C = 150 mA$ $V_{CE} = 10 V$
$h_{FE} (125^\circ C)$	DC Pulse Current Gain (Note 5)		270	650		270	650		$I_C = 150 mA$ $V_{CE} = 10 V$
h_{FE}	DC Pulse Current Gain (Note 5)	70	100		70	100			$I_C = 300 mA$ $V_{CE} = 10 V$
h_{FE}	DC Pulse Current Gain (Note 5)	45	60		45	60			$I_C = 500 mA$ $V_{CE} = 10 V$
h_{fe}	High Frequency Current Gain ($f = 100 MHz$)	2.5	4.0	6.0	2.5	4.0	6.0		$I_C = 50 mA$ $V_{CE} = 10 V$
$V_{CE(sat)}$	Pulsed Collector Saturation Voltage (Note 5)		0.04	0.07		0.04	0.07	Volts	$I_C = 10 mA$ $I_B = 1.0 mA$
$V_{CE(sat)}$	Pulsed Collector Saturation Voltage (Note 5)		0.15	0.18		0.15	0.18	Volts	$I_C = 150 mA$ $I_B = 15 mA$
$V_{CE(sat)} (125^\circ C)$	Pulsed Collector Saturation Voltage (Note 5)		0.18	0.36		0.18	0.36	Volts	$I_C = 150 mA$ $I_B = 15 mA$
$V_{CE(sat)}$	Pulsed Collector Saturation Voltage (Note 5)		0.25	0.31		0.25	0.31	Volts	$I_C = 300 mA$ $I_B = 30 mA$
$V_{CE(sat)}$	Pulsed Collector Saturation Voltage (Note 5)		0.38	0.50		0.38	0.50	Volts	$I_C = 500 mA$ $I_B = 50 mA$
$V_{BE(sat)}$	Pulsed Base Saturation Voltage (Note 5)		0.67	0.72		0.67	0.72	Volts	$I_C = 10 mA$ $I_B = 1.0 mA$
$V_{BE(sat)} (-55^\circ C)$	Pulsed Base Saturation Voltage (Note 5)		0.92	1.10		0.92	1.10	Volts	$I_C = 150 mA$ $I_B = 15 mA$
$V_{BE(sat)}$	Pulsed Base Saturation Voltage (Note 5)	0.78	0.82	0.90	0.78	0.82	0.90	Volts	$I_C = 150 mA$ $I_B = 15 mA$
$V_{BE(sat)} (125^\circ C)$	Pulsed Base Saturation Voltage (Note 5)	0.63	0.73		0.63	0.73		Volts	$I_C = 150 mA$ $I_B = 15 mA$
$V_{BE(sat)}$	Pulsed Base Saturation Voltage (Note 5)		0.95	1.05		0.95	1.05	Volts	$I_C = 300 mA$ $I_B = 30 mA$
$V_{BE(sat)}$	Pulsed Base Saturation Voltage (Note 5)		1.1	1.3		1.1	1.3	Volts	$I_C = 500 mA$ $I_B = 50 mA$
$V_{BE(on)}$	Pulsed Base Emitter On Voltage (Note 5)		0.75	0.88		0.75	0.88	Volts	$I_C = 150 mA$ $V_{CE} = 10 V$

*Planar is a patented Fairchild process.

FAIRCHILD
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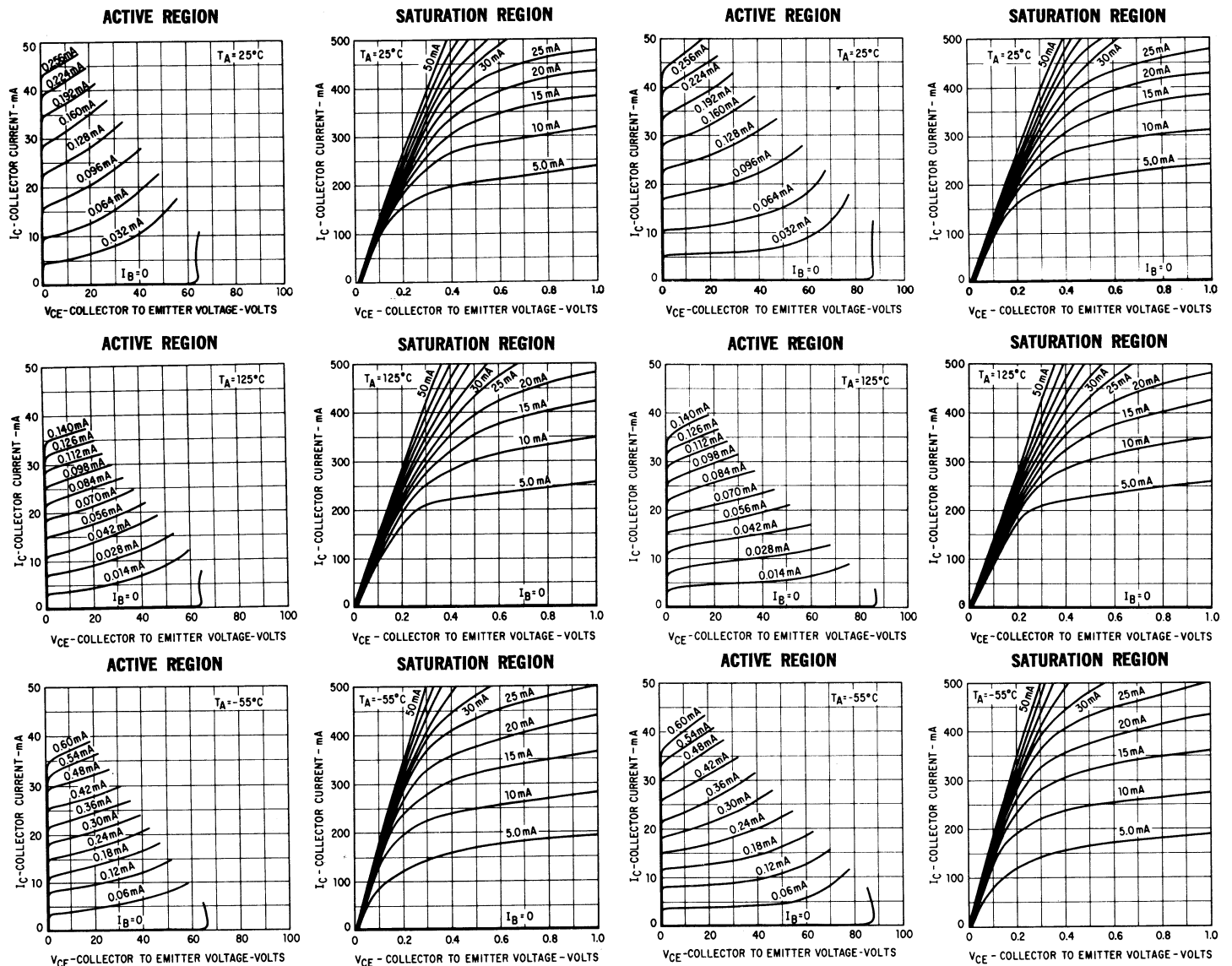
ELECTRICAL CHARACTERISTICS (25° Free Air Temperature unless otherwise noted)

SYMBOL	CHARACTERISTIC	2N4960 • 2N4962			2N4961 • 2N4963			UNIT	TEST CONDITIONS
		MIN.	TYP.	MAX.	MIN.	TYP.	MAX.		
$V_{CE0(sust)}$	Collector to Emitter Sustaining Voltage (Note 4 & 5)	60			80			Volts	$I_C = 10 \text{ mA}$ $I_B = 0$
BV_{CES}	Collector to Emitter Breakdown Voltage	60			80			Volts	$I_C = 10 \text{ } \mu\text{A}$ $I_B = 0$
BV_{CBO}	Collector to Base Breakdown Voltage	60			80			Volts	$I_C = 10 \text{ } \mu\text{A}$ $I_E = 0$
BV_{EBO}	Emitter to Base Breakdown Voltage	6.5			6.5			Volts	$I_C = 0$ $I_E = 10 \text{ } \mu\text{A}$
I_{CBO}	Collector Cutoff Current		1.0	10		1.0	10	nA	$I_E = 0$ $V_{CB} = 50 \text{ V}$
$I_{CBO}(125^\circ\text{C})$	Collector Cutoff Current		1.0	10		1.0	10	μA	$I_E = 0$ $V_{CB} = 50 \text{ V}$
I_{EBO}	Emitter Cutoff Current		1.0	10		1.0	10	nA	$I_C = 0$ $V_{EB} = 4.0 \text{ V}$
C_{cb}	Collector to Base Capacitance ($f = 1.0 \text{ MHz}$)		11	15		11	15	pF	$I_E = 0$ $V_{CB} = 10 \text{ V}$
C_{eb}	Emitter to Base Capacitance ($f = 1.0 \text{ MHz}$)		50	75		50	75	pF	$I_C = 0$ $V_{EB} = 0.5 \text{ V}$
t_{on}	Turn On Time (Note 6, Fig. 1)		70	150		70	150	ns	$I_C \approx 150 \text{ mA}$ $I_{B1} \approx 15 \text{ mA}$
t_{off}	Turn Off Time (Note 6, Fig. 1)		700	1000		700	1000	ns	$I_C \approx 150 \text{ mA}$ $I_{B2} \approx 15 \text{ mA}$
t_{on}	Turn On Time (Note 6, Fig. 1)		80			80		ns	$I_C \approx 300 \text{ mA}$ $I_{B1} \approx 30 \text{ mA}$
t_{off}	Turn Off Time (Note 6, Fig. 1)		600			600		ns	$I_C \approx 300 \text{ mA}$ $I_{B2} \approx 30 \text{ mA}$
t_{on}	Turn On Time (Note 6, Fig. 1)		100			100		ns	$I_C \approx 500 \text{ mA}$ $I_{B1} \approx 50 \text{ mA}$
t_{off}	Turn Off Time (Note 6, Fig. 1)		500			500		ns	$I_C \approx 500 \text{ mA}$ $I_{B2} \approx 50 \text{ mA}$

TYPICAL COLLECTOR AND BASE CHARACTERISTICS

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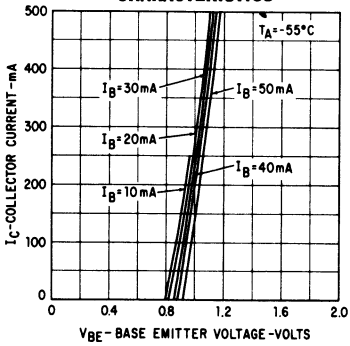
2N4961 • 2N4963



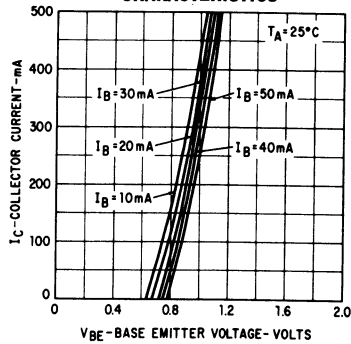
FAIRCHILD TRANSISTORS 2N4960 • 2N4961 • 2N4962 • 2N4963

TYPICAL ELECTRICAL CHARACTERISTICS

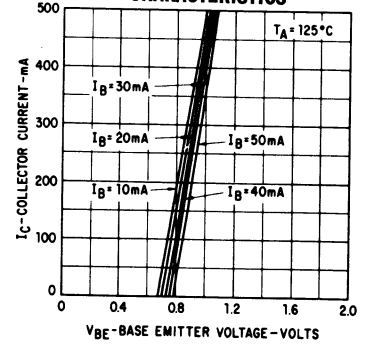
TYPICAL BASE CHARACTERISTICS



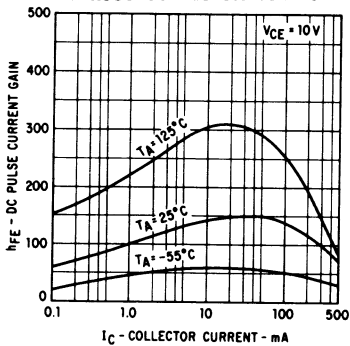
TYPICAL BASE CHARACTERISTICS



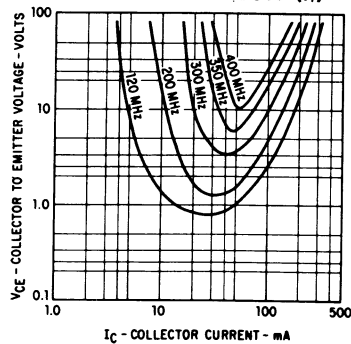
TYPICAL BASE CHARACTERISTICS



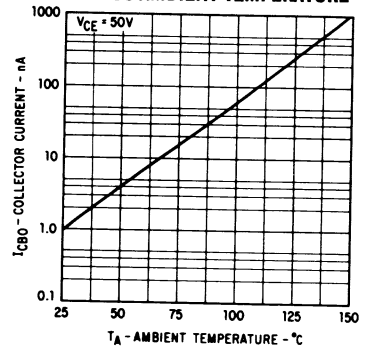
DC PULSE CURRENT GAIN VERSUS COLLECTOR VOLTAGE



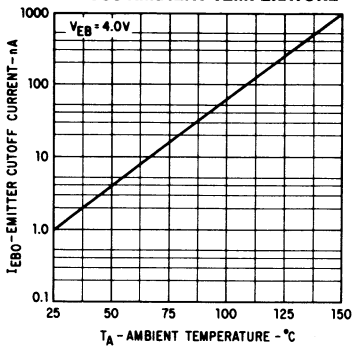
CONTOUR OF CONSTANT GAIN BANDWIDTH PRODUCT (f_T)



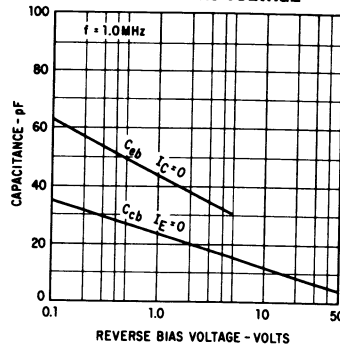
COLLECTOR REVERSE CURRENT VERSUS AMBIENT TEMPERATURE



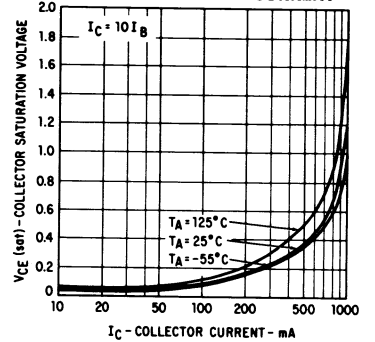
EMITTER CUTOFF CURRENT VERSUS AMBIENT TEMPERATURE



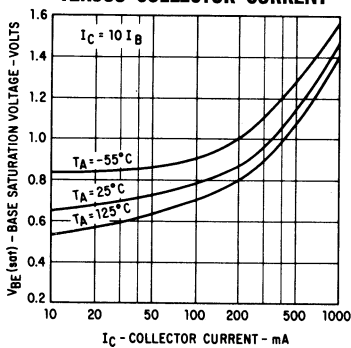
COLLECTOR-BASE AND EMITTER-BASE CAPACITANCE VERSUS REVERSE BIAS VOLTAGE



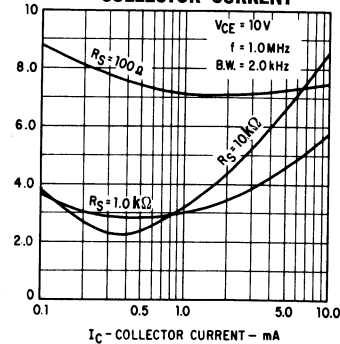
COLLECTOR SATURATION VOLTAGE VERSUS COLLECTOR CURRENT



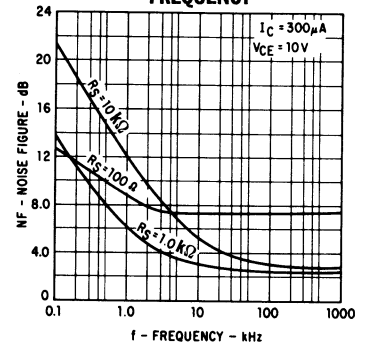
BASE SATURATION VOLTAGE VERSUS COLLECTOR CURRENT



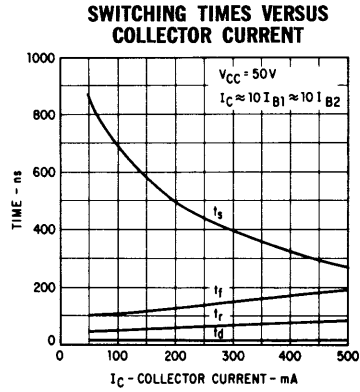
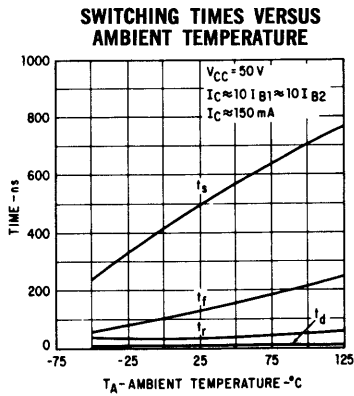
NOISE FIGURE VERSUS COLLECTOR CURRENT



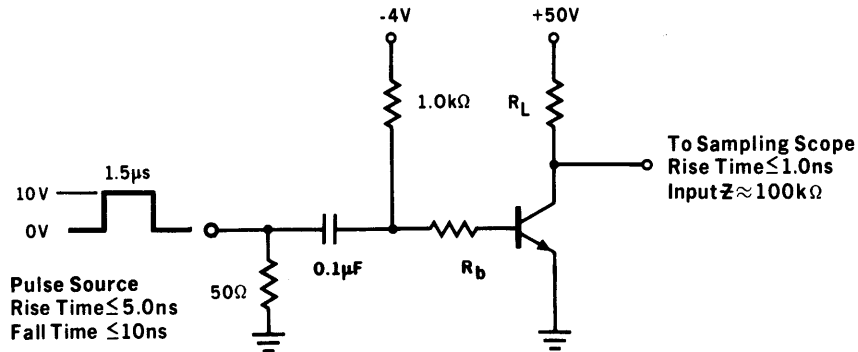
NOISE FIGURE VERSUS FREQUENCY



TYPICAL ELECTRICAL CHARACTERISTICS



t_{on} - t_{off} TEST CIRCUIT



I_C	R_b	R_L
150mA	314 Ω	330 Ω
300mA	157 Ω	167 Ω
500mA	94 Ω	100 Ω

NOTES:

1. These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
2. These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
3. These ratings give a maximum junction temperature of 200°C and junction to case thermal resistance of 50°C/Watt (derating factor of 20 mW/°C) for the 2N4960 and 2N4961; 117°C/Watt (derating factor of 8.6 mW/°C) for the 2N4962 and 2N4963. Junction to ambient thermal resistance of 219°C/Watt (derating factor of 4.6 mW/°C) for the 2N4960 and 2N4961. 350°C/Watt derating factor of 2.9 mW/°C for the 2N4962 and 2N4963.
4. Rating refers to a high-current point where collector-to-emitter voltage is lowest.
5. Pulse Conditions: length = 300 μs ; duty cycle = 1%.
6. See switching circuit for exact values of I_C , I_{B1} , and I_{B2} .

2N4998 • 2N5000

30 WATT NPN POWER TRANSISTORS

DIFFUSED SILICON PLANAR* TRANSISTORS

SEE 2N4999 • 2N5001 FOR PNP COMPLEMENT

- HIGH POWER -- 30 WATTS @ $T_C = 50^\circ\text{C}$, $V_{CE} = 40\text{ V}$
- HIGH VOLTAGE -- 80 V (MIN) V_{CEO}
- HIGH CURRENT SATURATION VOLTAGE -- 0.85 V (MAX) $V_{CE(sat)}$ @ $I_C = 2.0\text{ A}$
- HIGH FREQUENCY -- 50 AND 60 MHz (MIN) f_T
- BETA GUARANTEED @ 3 POINTS -- 50 mA, 1.0 A AND 2.0 A
- ISOLATED COLLECTOR PACKAGE -- NO ISOLATING HARDWARE REQUIRED
- DISCRETE EMITTER GEOMETRY WITH INTEGRATED FEEDBACK RESISTORS

ABSOLUTE MAXIMUM RATINGS (Note 1)

Maximum Temperatures

Storage Temperature

Operating Junction Temperature

Lead Temperature (Soldering, 60 second time limit)

-65°C to +200°C

-65°C to +200°C

+300°C

Maximum Power Dissipation

Total Dissipation at 50°C Case Temperature, $V_{CE} = 40\text{ V}$.

(See Maximum Permissible Power Curve and Note 4)

30 Watts

Maximum Voltages and Current

V_{CES} Collector to Emitter Voltage

V_{CEO} Collector to Emitter Voltage (Note 2)

V_{EBO} Emitter to Base Voltage

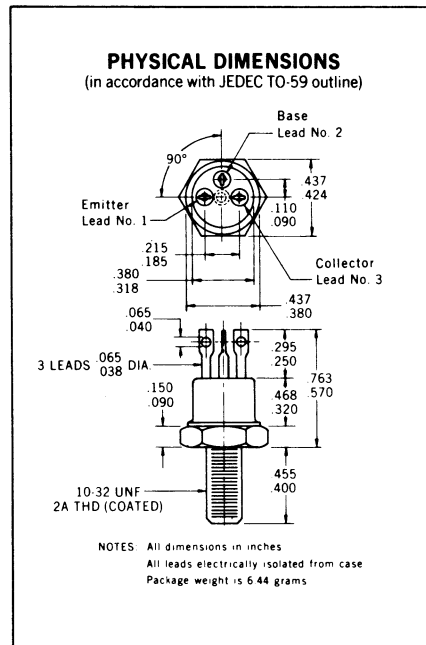
I_C Collector Current

100 Volts

80 Volts

6.0 Volts

2.0 Amps



ELECTRICAL CHARACTERISTICS (25° Case Temperature unless otherwise noted)

SYMBOL	CHARACTERISTIC	2N4998			2N5000			UNITS	TEST CONDITIONS
		MIN.	TYP.	MAX.	MIN.	TYP.	MAX.		
$V_{CEO(sust)}$	Collector to Emitter Sustaining Voltage (Notes 2 and 3)	80			80			Volts	$I_C = 100\text{ mA}$ $I_B = 0$
BV_{CES}	Collector to Emitter Breakdown Voltage	100			100			Volts	$I_C = 1.0\text{ mA}$ $V_{BE} = 0$
BV_{EBO}	Emitter to Base Breakdown Voltage	6.0			6.0			Volts	$I_C = 0$ $I_E = 1.0\text{ mA}$
h_{FE}	DC Pulse Current Gain (Note 3)	20	64		50	120			$I_C = 50\text{ mA}$ $V_{CE} = 5.0\text{ V}$
h_{FE}	DC Pulse Current Gain (Note 3)	30	63	90	70	110	200		$I_C = 1.0\text{ A}$ $V_{CE} = 5.0\text{ V}$
$h_{FE}(-55^\circ\text{C})$	DC Pulse Current Gain (Note 3)	15	45		35	63			$I_C = 1.0\text{ A}$ $V_{CE} = 5.0\text{ V}$
h_{FE}	DC Pulse Current Gain (Note 3)	15	33		30	56			$I_C = 2.0\text{ A}$ $V_{CE} = 5.0\text{ V}$
h_{fe}	High Frequency Current Gain ($f = 20\text{ MHz}$)	2.5	3.8		3.0	4.3			$I_C = 0.2\text{ A}$ $V_{CE} = 5.0\text{ V}$
$V_{CE(sat)}$	Pulsed Collector Saturation Voltage (Note 3)		0.38	0.46		0.38	0.46	Volts	$I_C = 1.0\text{ A}$ $I_B = 0.1\text{ A}$
$V_{CE(sat)}$	Pulsed Collector Saturation Voltage (Note 3)		0.75	0.85		0.75	0.85	Volts	$I_C = 2.0\text{ A}$ $I_B = 0.2\text{ A}$

Additional Electrical Characteristics on page 2
Notes on page 2

*Planar is a patented Fairchild process.

FAIRCHILD
SEMICONDUCTOR
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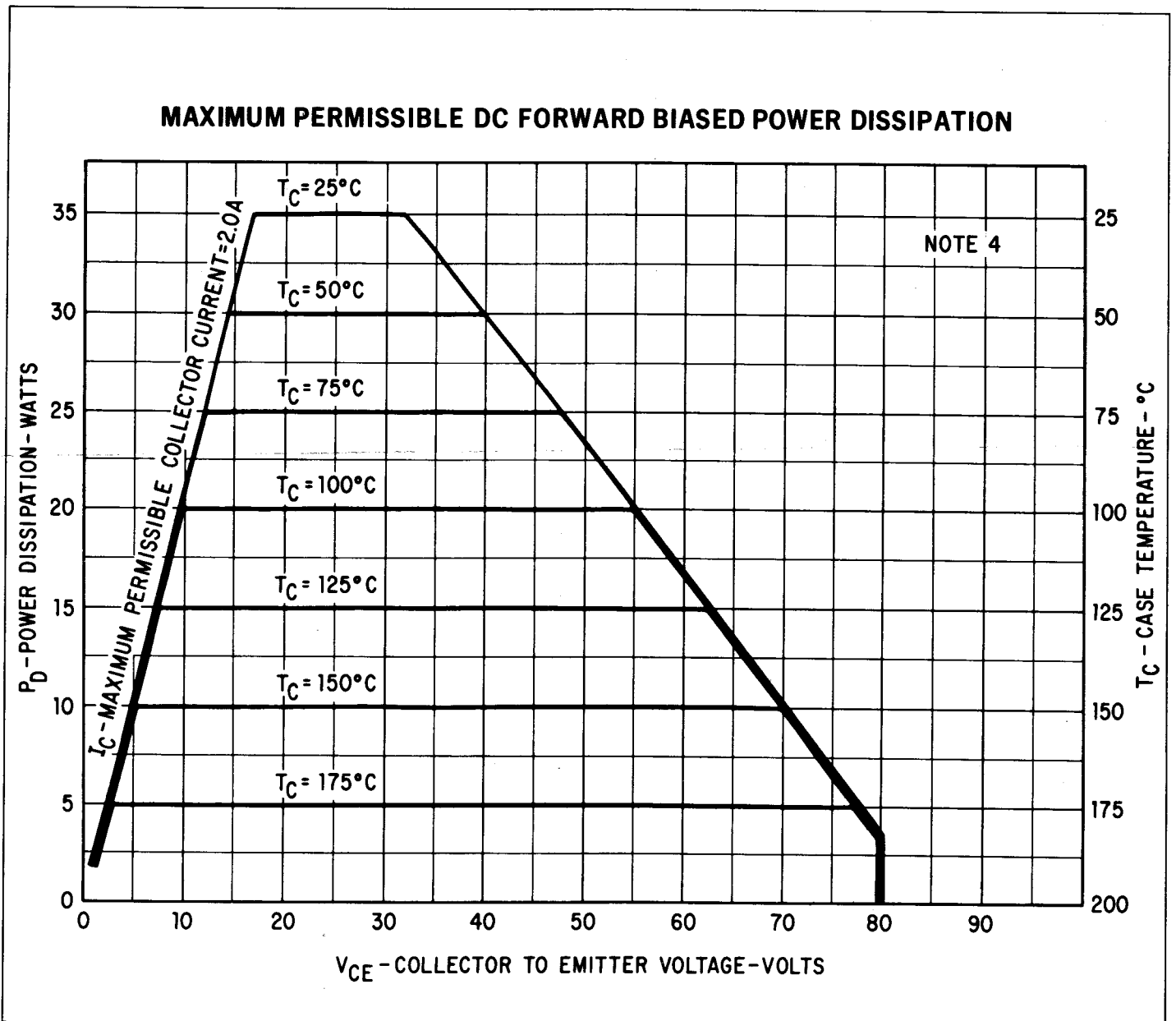
FAIRCHILD TRANSISTORS 2N4998 • 2N5000

ELECTRICAL CHARACTERISTICS (25° Case Temperature unless otherwise noted)

SYMBOL	CHARACTERISTIC	2N4998			2N5000			UNITS	TEST CONDITIONS
		MIN.	TYP.	MAX.	MIN.	TYP.	MAX.		
$V_{BE}(sat)$	Pulsed Base Saturation Voltage (Note 3)	0.98	1.2		0.98	1.2		Volts	$I_C = 1.0 A$ $I_B = 0.1 A$
$V_{BE}(sat)$	Pulsed Base Saturation Voltage (Note 3)	1.30	1.5		1.30	1.5		Volts	$I_C = 2.0 A$ $I_B = 0.2 A$
$V_{BE}(on)$	Pulsed Base Emitter "ON" Voltage (Note 3)		1.5			1.5		Volts	$I_C = 2.0 A$ $V_{CE} = 5.0 V$
I_{CES}	Collector Cutoff Current	.002	1.0		.002	1.0		μA	$V_{CE} = 60 V$ $V_{BE} = 0$
I_{EBO}	Emitter Cutoff Current		1.0			1.0		μA	$I_C = 0$ $V_{EB} = 5.0 V$
$I_{CEX}(150^\circ C)$	Collector Reverse Current		500			500		μA	$V_{CE} = 60 V$ $V_{EB} = 2.0 V$
C_{cb}	Collector to Base Capacitance	30	70		30	70		pF	$I_E = 0$ $V_{CB} = 10 V$

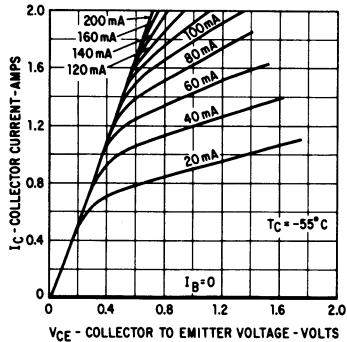
NOTES:

- (1) These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
- (2) This rating refers to a high current point where collector to emitter voltage is lowest. For more information send for Fairchild Publication APP-4/2.
- (3) Pulse Conditions: length = 300 μs ; duty cycle = 1%.
- (4) Contact factory for maximum permissible power under pulsed or reverse biased operating conditions.

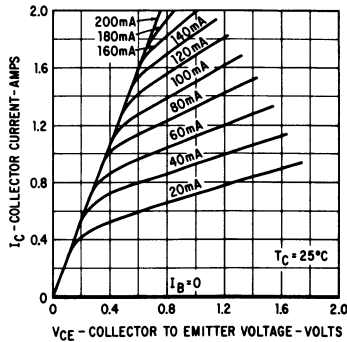


TYPICAL ELECTRICAL CHARACTERISTICS

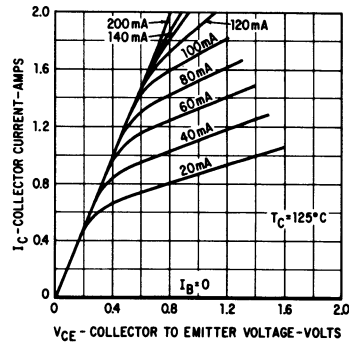
COLLECTOR CHARACTERISTICS* SATURATION REGION



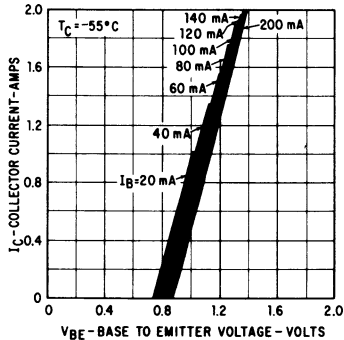
COLLECTOR CHARACTERISTICS* SATURATION REGION



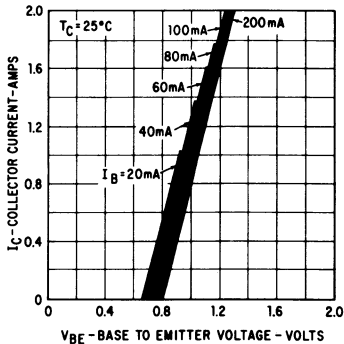
COLLECTOR CHARACTERISTICS* SATURATION REGION



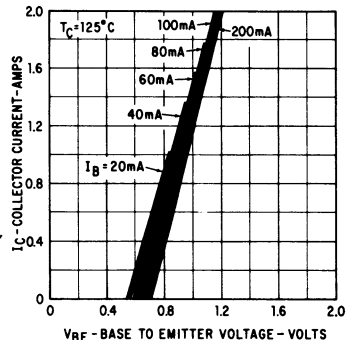
BASE CHARACTERISTICS*



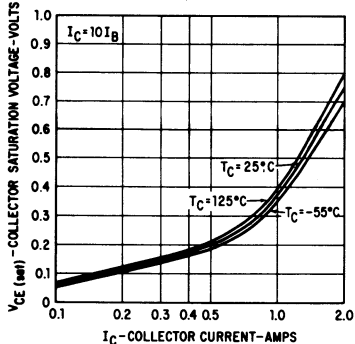
BASE CHARACTERISTICS*



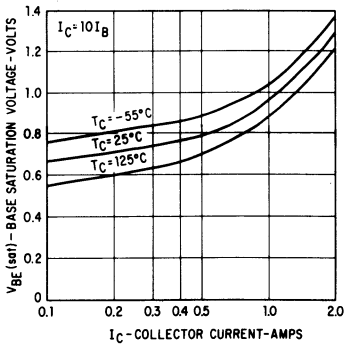
BASE CHARACTERISTICS*



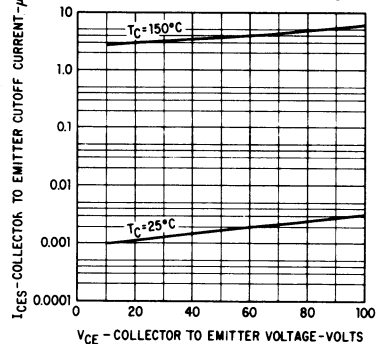
COLLECTOR SATURATION VOLTAGE VERSUS COLLECTOR CURRENT



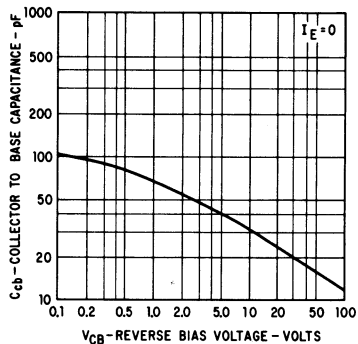
BASE SATURATION VOLTAGE VERSUS COLLECTOR CURRENT



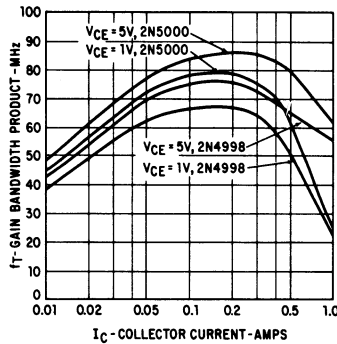
COLLECTOR CUTOFF CURRENT VERSUS COLLECTOR VOLTAGE



COLLECTOR TO BASE CAPACITANCE VERSUS REVERSE BIAS VOLTAGE



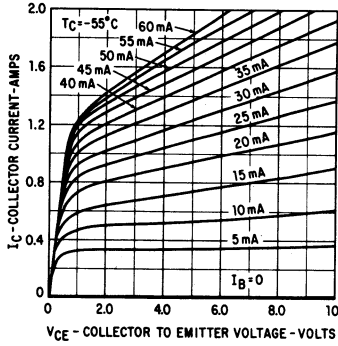
GAIN BANDWIDTH PRODUCT VERSUS COLLECTOR CURRENT



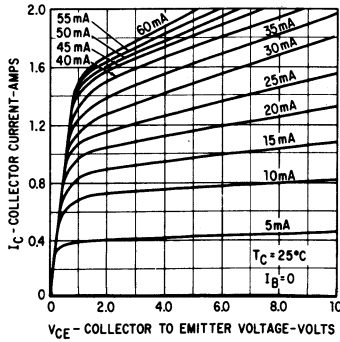
* Single family characteristic on Transistor Curve Tracer.

TYPICAL ELECTRICAL CHARACTERISTICS
2N4998

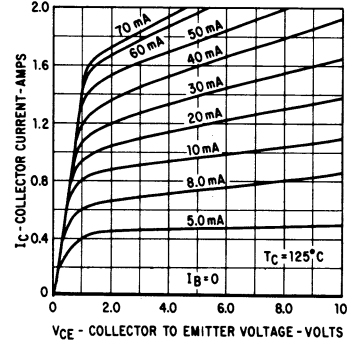
COLLECTOR CHARACTERISTICS*
ACTIVE REGION



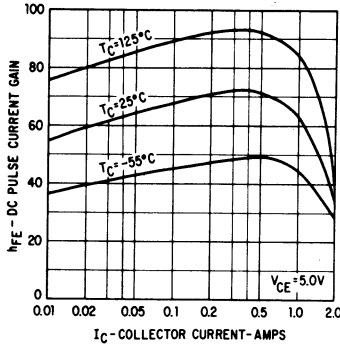
COLLECTOR CHARACTERISTICS*
ACTIVE REGION



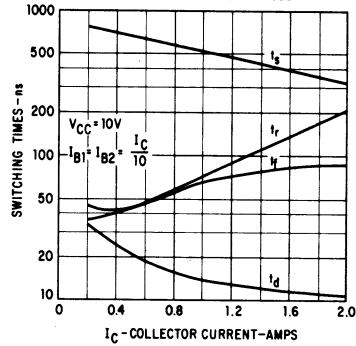
COLLECTOR CHARACTERISTICS*
ACTIVE REGION



DC PULSE CURRENT GAIN
VERSUS COLLECTOR CURRENT

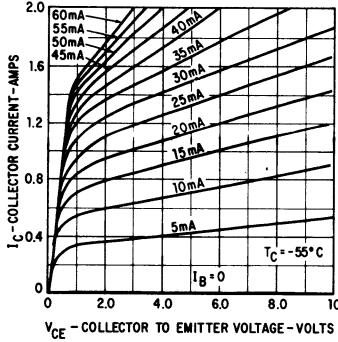


SWITCHING TIMES VERSUS
COLLECTOR CURRENT

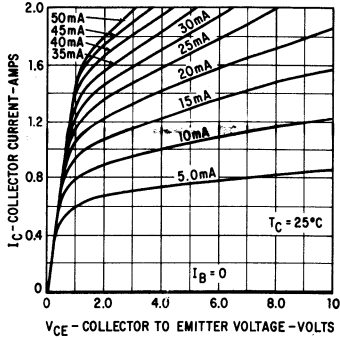


2N5000

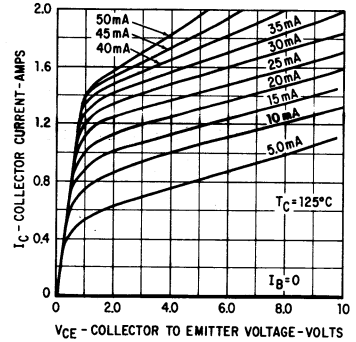
COLLECTOR CHARACTERISTICS*
ACTIVE REGION



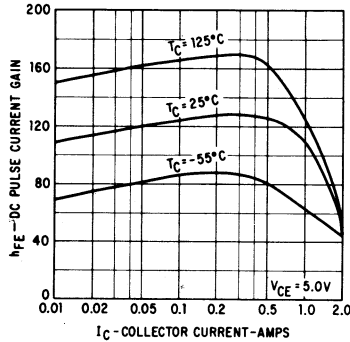
COLLECTOR CHARACTERISTICS*
ACTIVE REGION



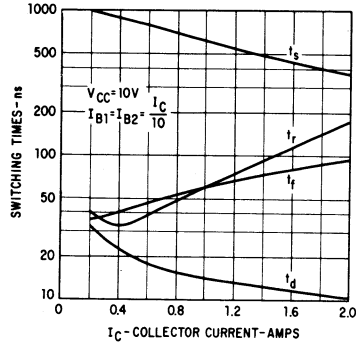
COLLECTOR CHARACTERISTICS*
ACTIVE REGION



DC PULSE CURRENT GAIN
VERSUS COLLECTOR CURRENT



SWITCHING TIMES VERSUS
COLLECTOR CURRENT



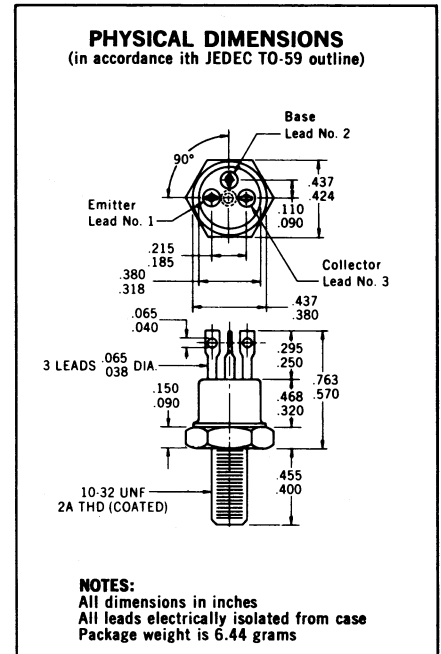
*Single Family Characteristics on Transistor Curve Tracer.

2N4999 • 2N5001

30 WATT PNP POWER TRANSISTORS

DIFFUSED SILICON PLANAR* TRANSISTORS
SEE 2N4998 • 2N5000 FOR NPN COMPLEMENT

- HIGH POWER 30 WATTS AT $T_C = 50^\circ\text{C}$, $V_{CE} = -40\text{ V}$
- HIGH VOLTAGE $-80\text{ V (MIN) } V_{CEO}$
- HIGH CURRENT SATURATION VOLTAGE $-0.85\text{ V (MAX) } V_{CE(sat)}$ AT $I_C = 2.0\text{ A}$
- HIGH FREQUENCY 50 AND 60 MHz (MIN) f_T
- BETA GUARANTEED AT 3 POINTS 50 mA, 1.0 A AND 2.0 A
- ISOLATED COLLECTOR PACKAGE NO ISOLATING HARDWARE REQUIRED
- DISCRETE EMITTER GEOMETRY WITH INTEGRATED FEEDBACK RESISTORS



ABSOLUTE MAXIMUM RATINGS (Note 1)

Maximum Temperatures

- Storage Temperature $-65^\circ\text{C to } +200^\circ\text{C}$
- Operating Junction Temperature $-65^\circ\text{C to } +200^\circ\text{C}$
- Lead Temperature (Soldering, 60 second time limit) $+300^\circ\text{C}$

Maximum Power Dissipation

- Total Dissipation at 50°C Case Temperature, $V_{CE} = -40\text{ V}$ 30 Watts
(See Maximum Permissible Power Curve and Note 4)

Maximum Voltages and Current

- V_{CES} Collector to Emitter Voltage -100 Volts
- V_{CEO} Collector to Emitter Voltage (Note 2) -80 Volts
- V_{EBO} Emitter to Base Voltage -5.5 Volts
- I_C Collector Current 2.0 Amps

ELECTRICAL CHARACTERISTICS (25°C Case Temperature unless otherwise noted)

SYMBOL	CHARACTERISTICS	2N4999			2N5001			UNITS	TEST CONDITIONS
		MIN.	TYP.	MAX.	MIN.	TYP.	MAX.		
$V_{CEO(sus)}$	Collector to Emitter Sustaining Voltage (Notes 2 and 3)	-80			-80			Volts	$I_C = 100\text{ mA}$ $I_B = 0$
BV_{CES}	Collector to Emitter Breakdown Voltage	-100			-100			Volts	$I_C = 1.0\text{ mA}$ $V_{BE} = 0$
BV_{EBO}	Emitter to Base Breakdown Voltage	-5.5			-5.5			Volts	$I_C = 0$ $I_E = 1.0\text{ mA}$
h_{FE}	DC Pulse Current Gain (Note 3)	20	39		50	85			$I_C = 50\text{ mA}$ $V_{CE} = -5.0\text{ V}$
h_{FE}	DC Pulse Current Gain (Note 3)	30	40	90	70	88	200		$I_C = 1.0\text{ A}$ $V_{CE} = -5.0\text{ V}$
$h_{FE}(-55^\circ\text{C})$	DC Pulse Current Gain (Note 3)	15	24		35	52			$I_C = 1.0\text{ A}$ $V_{CE} = -5.0\text{ V}$
h_{FE}	DC Pulse Current Gain (Note 3)	15	28		30	50			$I_C = 2.0\text{ A}$ $V_{CE} = -5.0\text{ V}$
h_{fe}	High Frequency Current Gain ($f = 20\text{ MHz}$)	2.5	4.8		3.0	6.1			$I_C = 0.2\text{ A}$ $V_{CE} = -5.0\text{ V}$
$V_{CE(sat)}$	Pulsed Collector Saturation Voltage (Note 3)		-0.38	-0.46		-0.38	-0.46	Volts	$I_C = 1.0\text{ A}$ $I_B = 0.1\text{ A}$
$V_{CE(sat)}$	Pulsed Collector Saturation Voltage (Note 3)		-0.73	-0.85		-0.73	-0.85	Volts	$I_C = 2.0\text{ A}$ $I_B = 0.2\text{ A}$

Additional Electrical Characteristics on page 2
Notes on page 2

*Planar is a patented Fairchild process.



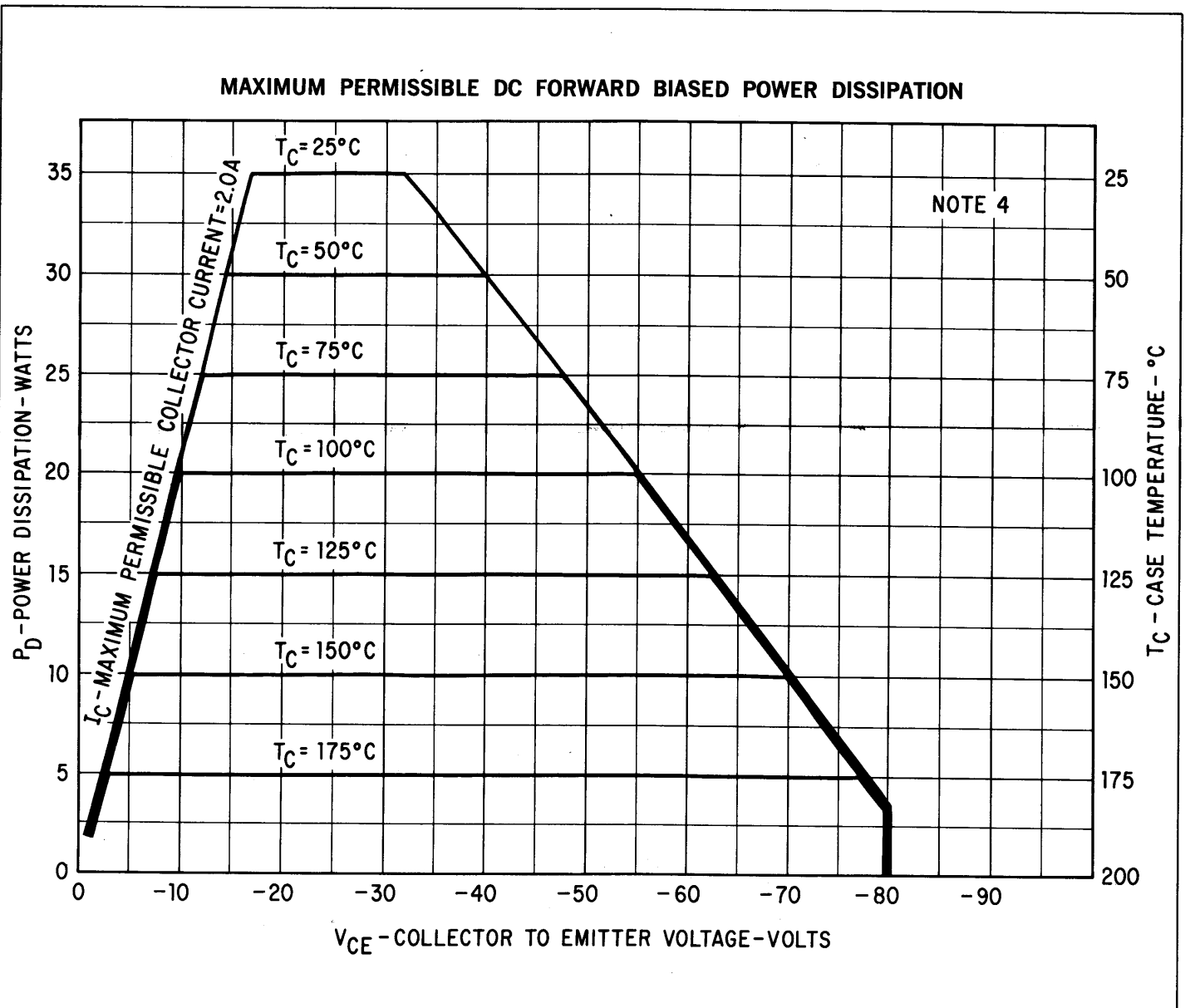
FAIRCHILD TRANSISTORS 2N4999 • 2N5001

ELECTRICAL CHARACTERISTICS (25°C Case Temperature unless otherwise noted)

SYMBOL	CHARACTERISTICS	2N4999			2N5001			UNITS	TEST CONDITIONS	
		MIN.	TYP.	MAX.	MIN.	TYP.	MAX.			
$V_{BE(sat)}$	Pulsed Base Saturation Voltage (Note 3)	-0.96	-1.2		-0.96	-1.2		Volts	$I_C = 1.0 A$	$I_B = 0.1 A$
$V_{BE(sat)}$	Pulsed Base Saturation Voltage (Note 3)	-1.28	-1.5		-1.28	-1.5		Volts	$I_C = 2.0 A$	$I_B = 0.2 A$
$V_{BE(on)}$	Pulsed Base Emitter "ON" Voltage (Note 3)		-1.5			-1.5		Volts	$I_C = 2.0 A$	$V_{CE} = -5.0 V$
I_{CES}	Collector Cutoff Current	.002	1.0		.002	1.0		μA	$V_{CE} = -60 V$	$V_{BE} = 0$
I_{EBO}	Emitter Cutoff Current		1.0			1.0		μA	$I_C = 0$	$V_{EB} = -4.0 V$
$I_{CEX(150^\circ C)}$	Collector Reverse Current		500			500		μA	$V_{CE} = -60 V$	$V_{EB} = -2.0 V$
C_{cb}	Collector to Base Capacitance	46	120		46	120		pF	$I_E = 0$	$V_{CB} = -10 V$

NOTES:

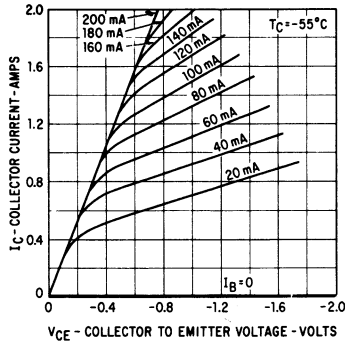
- (1) These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
- (2) This rating refers to a high current point where collector to emitter voltage is lowest. For more information send for Fairchild Publication APP-4/2.
- (3) Pulse Conditions: length = 300 μs ; duty cycle = 1%.
- (4) Contact factory for maximum permissible power under pulsed or reverse biased operating conditions.



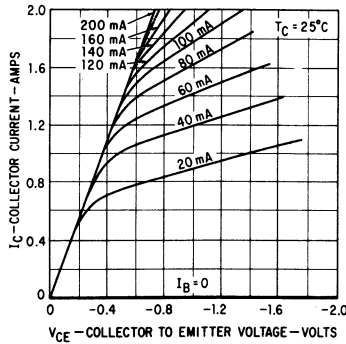
TYPICAL ELECTRICAL CHARACTERISTICS

→ 102

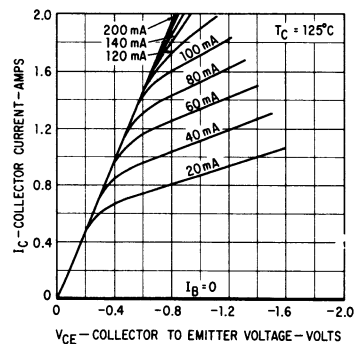
COLLECTOR CHARACTERISTICS* SATURATION REGION



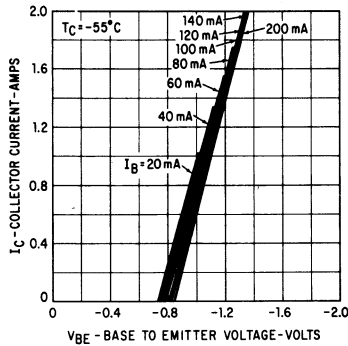
COLLECTOR CHARACTERISTICS* SATURATION REGION



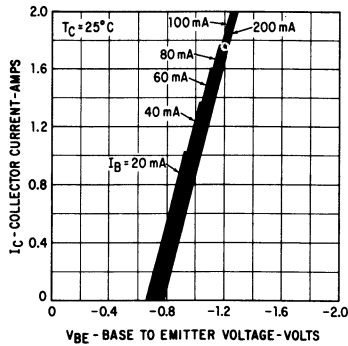
COLLECTOR CHARACTERISTICS* SATURATION REGION



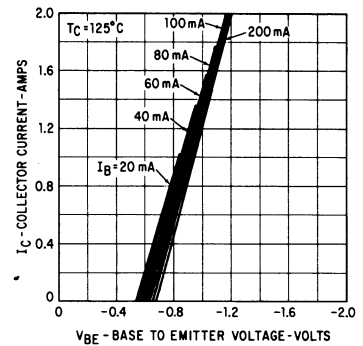
BASE CHARACTERISTICS*



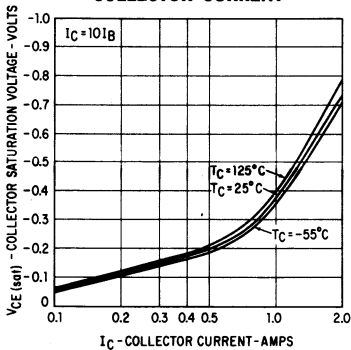
BASE CHARACTERISTICS*



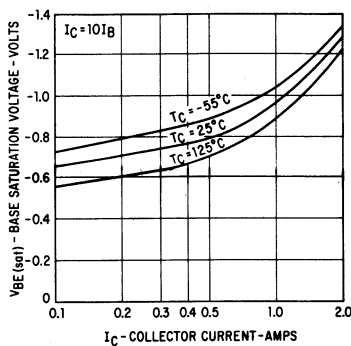
BASE CHARACTERISTICS*



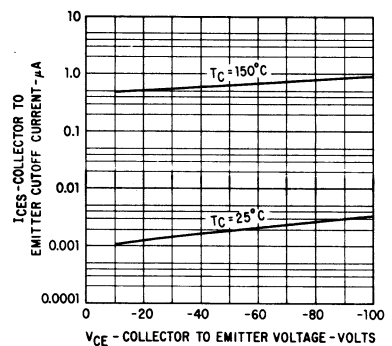
COLLECTOR SATURATION VOLTAGE VERSUS COLLECTOR CURRENT



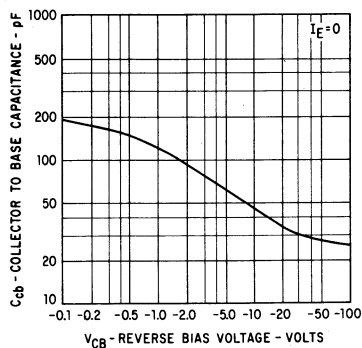
BASE SATURATION VOLTAGE VERSUS COLLECTOR CURRENT



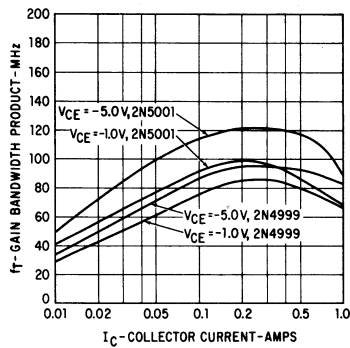
COLLECTOR CUTOFF CURRENT VERSUS COLLECTOR VOLTAGE



COLLECTOR TO BASE CAPACITANCE VERSUS REVERSE BIAS VOLTAGE



GAIN BANDWIDTH PRODUCT VERSUS COLLECTOR CURRENT

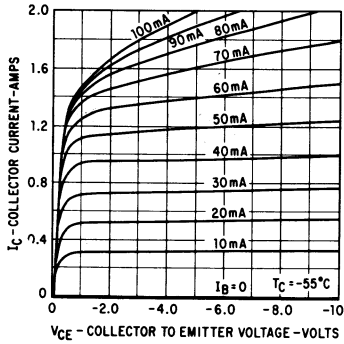


* Single family characteristic on Transistor Curve Tracer.

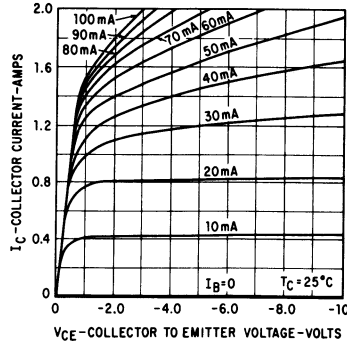
TYPICAL ELECTRICAL CHARACTERISTICS

2N4999

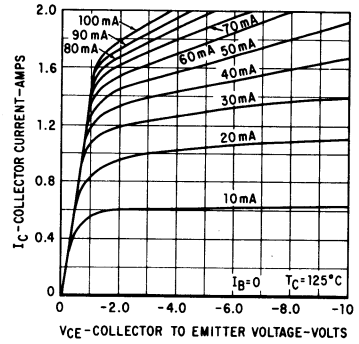
COLLECTOR CHARACTERISTICS*
ACTIVE REGION



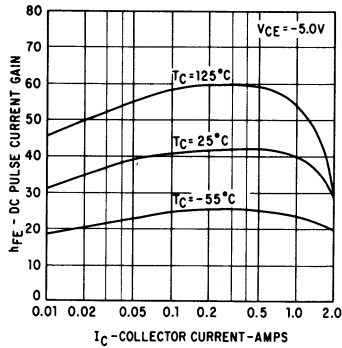
COLLECTOR CHARACTERISTICS*
ACTIVE REGION



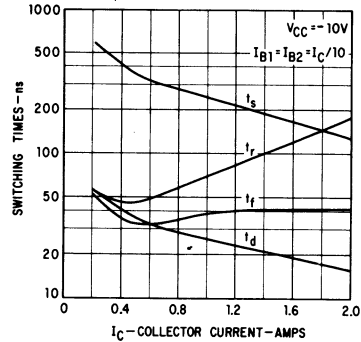
COLLECTOR CHARACTERISTICS*
ACTIVE REGION



DC PULSE CURRENT GAIN
VERSUS COLLECTOR CURRENT

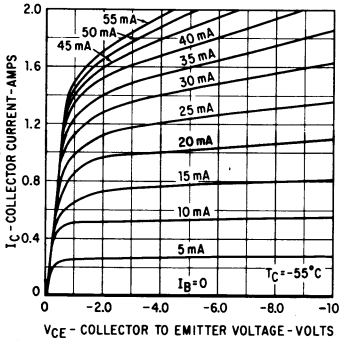


SWITCHING TIMES VERSUS
COLLECTOR CURRENT

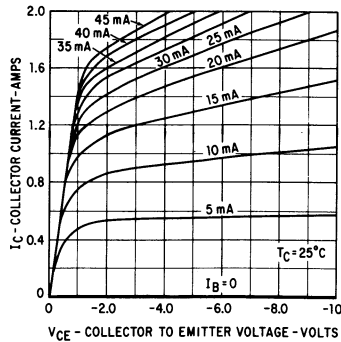


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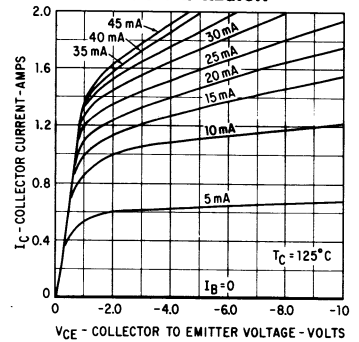
COLLECTOR CHARACTERISTICS*
ACTIVE REGION



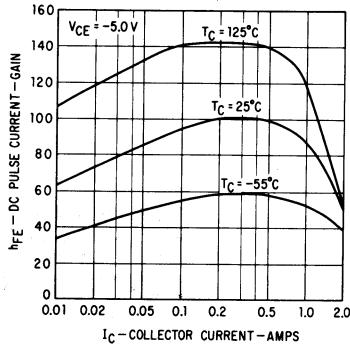
COLLECTOR CHARACTERISTICS*
ACTIVE REGION



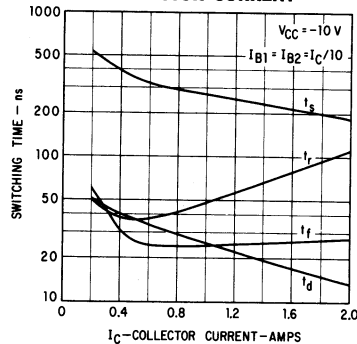
COLLECTOR CHARACTERISTICS*
ACTIVE REGION



DC PULSE CURRENT GAIN
VERSUS COLLECTOR CURRENT



SWITCHING TIMES VERSUS
COLLECTOR CURRENT



* Single family characteristic on Transistor Curve Tracer.